Application/Control No. Applicant(s)/Patent Under Reexamination 10/602,374 CHIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2826 Fazli Erdem **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0050815	12-2001	Ishihara et al.	359/566
	В	US-2003/0112515	06-2003	Nakabayashi, Masaaki	359/571
	С	US-2002/0110328	08-2002	Bischel et al.	385/49
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.